

**Search Notes**

Application/Control No.

10/656,382

Examiner

Sunray Chang

Applicant(s)/Patent under  
Reexamination

EIJI ET AL.

Art Unit

2121

**SEARCHED**

Class	Subclass	Date	Examiner
700	29, 40, 28, 103, 31, 19, 28.	8/8/2005	SC
123	19-42,250	8/8/2005	SC

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST (USPAT, US_PGPUB, JPO, EPO, DERWENT, IBM_TDB)	8/8/2005	SC